

isc N-Channel MOSFET Transistor

TK100E06N1, ITK100E06N1

• FEATURES

- Low drain-source on-resistance:
 $R_{DS(on)} \leq 2.3\text{m}\Omega$. ($V_{GS} = 10\text{ V}$)
- Enhancement mode:
 $V_{th} = 2.0$ to 4.0V ($V_{DS} = 10\text{ V}$, $I_D = 1.0\text{mA}$)
- 100% avalanche tested
- Minimum Lot-to-Lot variations for robust device performance and reliable operation

• DESCRIPTION

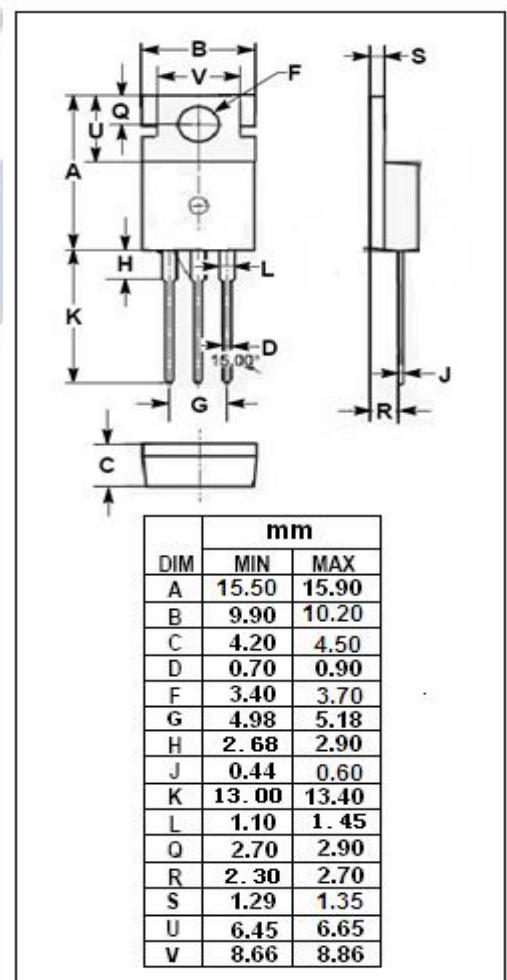
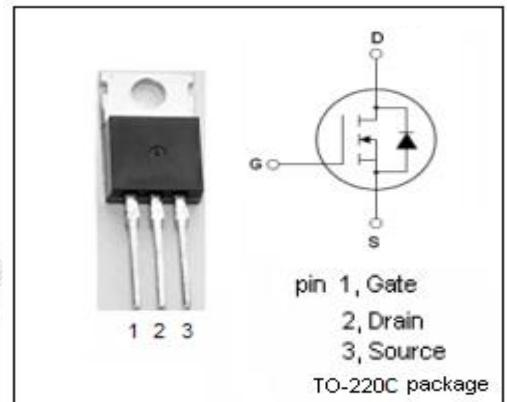
- Switching Voltage Regulators

• ABSOLUTE MAXIMUM RATINGS($T_a=25^\circ\text{C}$)

SYMBOL	PARAMETER	VALUE	UNIT
V_{DSS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current-Continuous	100	A
I_{DM}	Drain Current-Single Pulsed	627	A
P_D	Total Dissipation @ $T_c=25^\circ\text{C}$	255	W
T_j	Max. Operating Junction Temperature	150	$^\circ\text{C}$
T_{stg}	Storage Temperature	-55~150	$^\circ\text{C}$

• THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	MAX	UNIT
$R_{th(ch-c)}$	Channel-to-case thermal resistance	0.49	$^\circ\text{C/W}$
$R_{th(ch-a)}$	Channel-to-ambient thermal resistance	83.3	$^\circ\text{C/W}$



isc N-Channel MOSFET Transistor**TK100E06N1, ITK100E06N1****ELECTRICAL CHARACTERISTICS** $T_c=25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}; I_D=10\text{mA}$	60			V
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=10\text{V}; I_D=1.0\text{mA}$	2.0		4.0	V
$R_{DS(\text{on})}$	Drain-Source On-Resistance	$V_{GS}=10\text{V}; I_D=50\text{A}$			2.3	$\text{m}\Omega$
I_{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 20\text{V}; V_{DS} = 0\text{V}$			± 0.1	μA
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=60\text{V}; V_{GS}=0\text{V}$			10	μA
$V_{SD(\text{F})}$	Diode forward voltage	$I_{DR}=100\text{A}, V_{GS}=0\text{V}$			1.2	V